

# MBN1200E17D

Silicon N-channel IGBT

## FEATURES

- \* High speed, low loss IGBT module.
- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise due to ultra soft fast recovery diode.
- \* High reliability, high durability module.
- \* High thermal fatigue durability.  
( $\Delta T_c=70^\circ\text{C}$ ,  $N>30,000$ cycles)
- \* Isolated heat sink (terminal to base).

## ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ )

Item	Symbol	Unit	MBN1200E17D
Collector Emitter Voltage	$V_{CES}$	V	1,700
Gate Emitter Voltage	$V_{GES}$	V	$\pm 20$
Collector Current	DC	$I_C$	1,200
	1ms	$I_{Cp}$	2,400
Forward Current	DC	$I_F$	1,200
	1ms	$I_{FM}$	2,400
Junction Temperature	$T_j$	$^\circ\text{C}$	-40 ~ +125
Storage Temperature	$T_{stg}$	$^\circ\text{C}$	-40 ~ +125
Isolation Voltage	$V_{ISO}$	$V_{RMS}$	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/10 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value  $1.8\pm 0.2/9\pm 1\text{N}\cdot\text{m}$ (2) Recommended Value  $5.5\pm 0.5\text{N}\cdot\text{m}$ 

## ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	$I_{CES}$	mA	-	-	10	$V_{CE}=1,700\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=25^\circ\text{C}$
Gate Emitter Leakage Current	$I_{GES}$	nA	-500	-	+500	$V_{CE}=1,700\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	2.0	2.7	3.3	$V_{GE}=\pm 20\text{V}$ , $V_{CE}=0\text{V}$ , $T_j=25^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(TO)}$	V	5.0	6.5	8.0	$V_{CE}=10\text{V}$ , $I_C=120\text{mA}$ , $T_j=25^\circ\text{C}$
Input Capacitance	$C_{ies}$	nF	-	100	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Internal Gate Resistance	$R_{ge}$	$\Omega$	-	0.8	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Switching Times	Rise Time	$t_r$	-	0.6	1.0	$V_{CC}=900\text{V}$ , $I_C=1,200\text{A}$
	Turn On Time	$t_{on}$	-	0.9	1.8	$L=65\text{nH}$ , $C_{GE}=120\text{nF}$ (3)
	Fall Time	$t_f$	-	0.3	0.7	$R_G=1.5\Omega$ (3)
	Turn Off Time	$t_{off}$	-	1.4	3.4	$V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
Peak Forward Voltage Drop	$V_{FM}$	V	1.3	1.9	2.5	$I_F=1,200\text{A}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
Reverse Recovery Time	$t_{rr}$	$\mu\text{s}$	-	0.5	1.0	$V_{CC}=900\text{V}$ , $I_C=I_F=1,200\text{A}$
Turn On Loss	$E_{on(10\%)}$	J/P	0.09	0.25	0.4	$L=65\text{nH}$ , $C_{GE}=120\text{nF}$ (3)
Turn Off Loss	$E_{off(10\%)}$	J/P	0.18	0.35	0.5	$R_G=1.5\Omega$ (3)
Reverse Recovery Loss	$E_{rr(10\%)}$	J/P	0.18	0.4	0.6	$V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
Stray inductance module	$L_{SCE}$	nH	-	18	-	
Thermal Impedance	IGBT	$R_{th(j-c)}$	-	-	0.018	Junction to case
	FWD	$R_{th(j-c)}$	-	-	0.030	
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.008	-	Case to fin

Notes:(3)  $R_G$  and  $C_{GE}$  value is the test condition's value for evaluation of the switching times, not recommended value.Please, determine the suitable  $R_G$  and  $C_{GE}$  value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

\* Please contact our representatives at order.

\* For improvement, specifications are subject to change without notice.

\* For actual application, please confirm this spec sheet is the newest revision.

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## DEFINITION OF TEST CIRCUIT

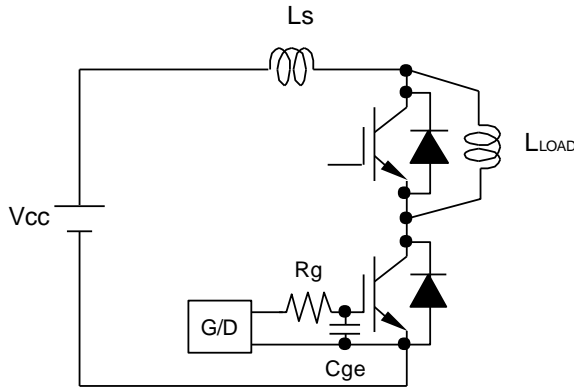


Fig.1 Switching test circuit

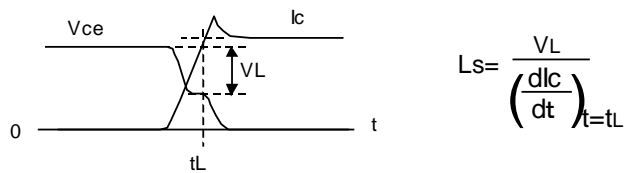


Fig.2 Definition of stray inductance

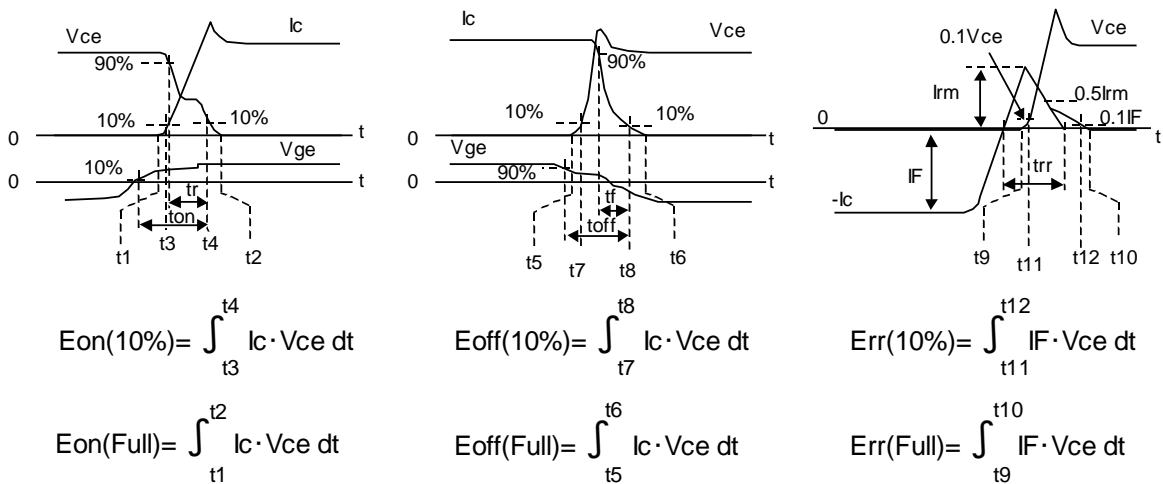
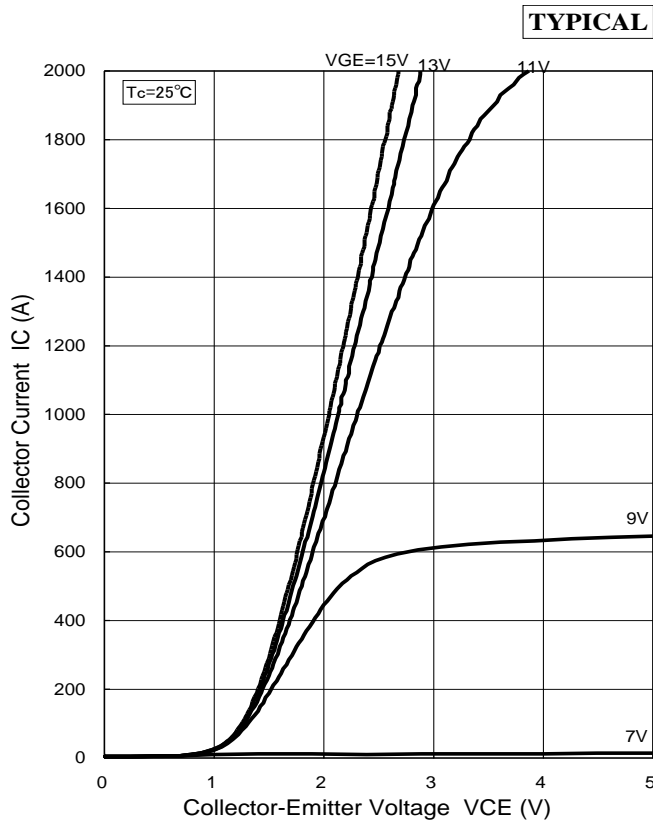


Fig.3 Definition of switching loss

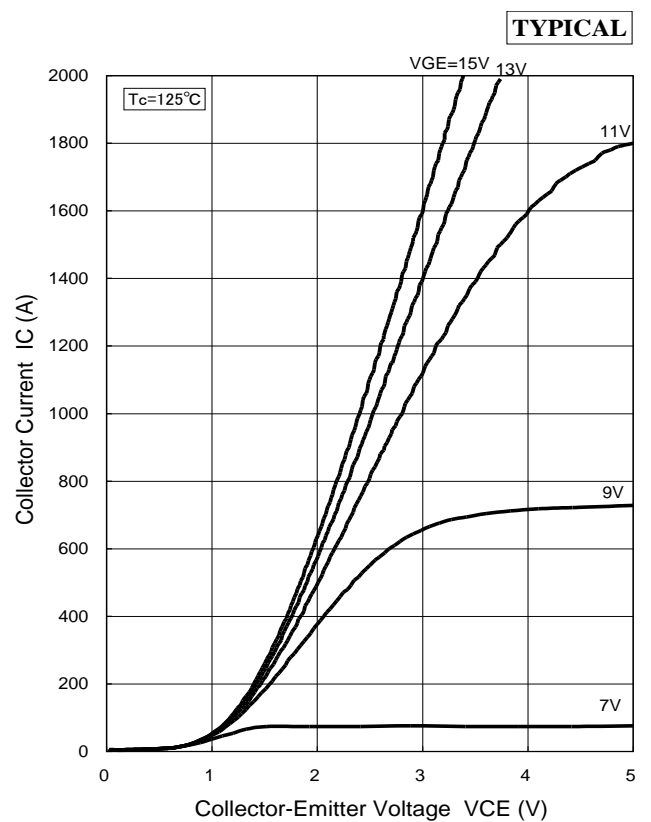
# MBN1200E17D

## CHARACTERISTICS CURVE

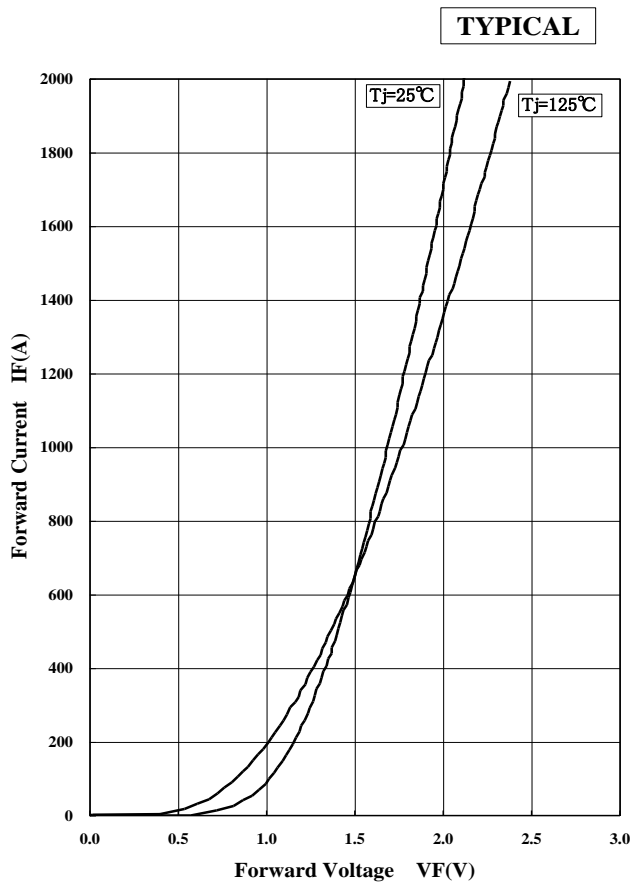
### STATIC CHARACTERISTICS



Collector Current vs. Collector to Emmitter Voltage



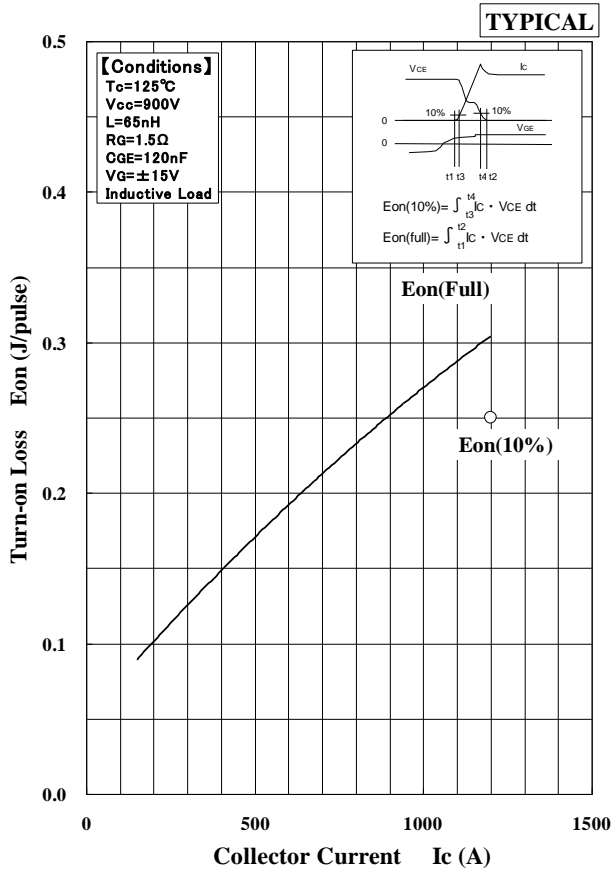
Collector Current vs. Collector to Emmitter Voltage



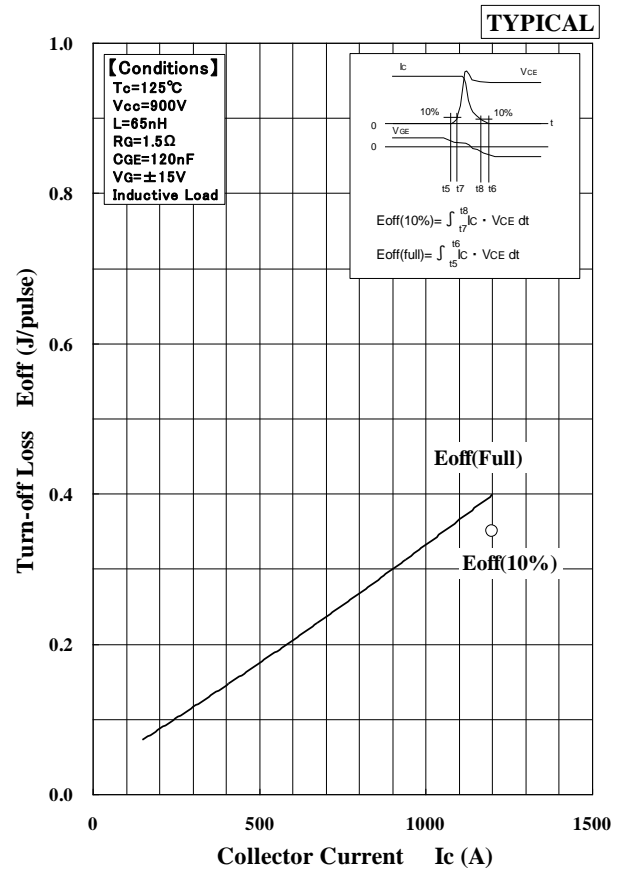
Forward Voltage of free-wheeling diode

# MBN1200E17D

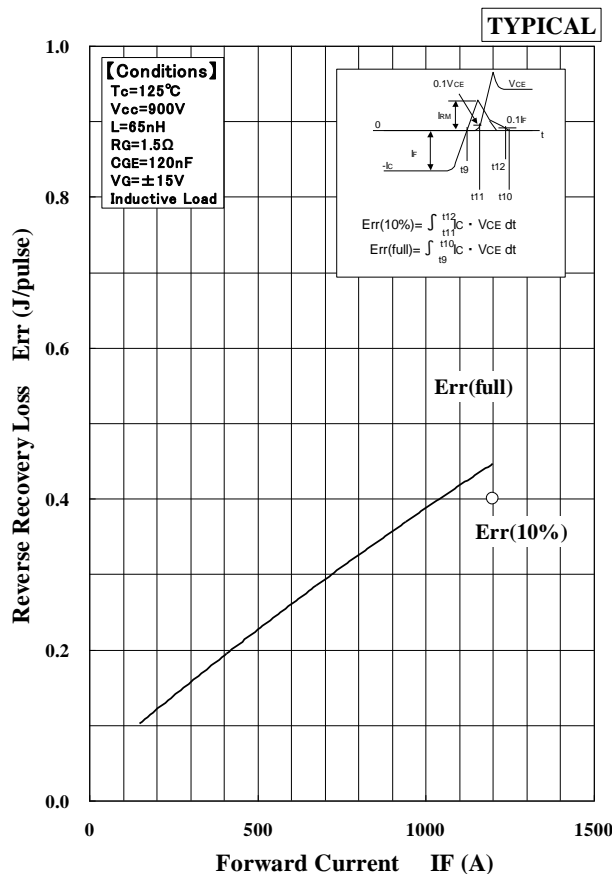
## DYNAMIC CHARACTERISTICS



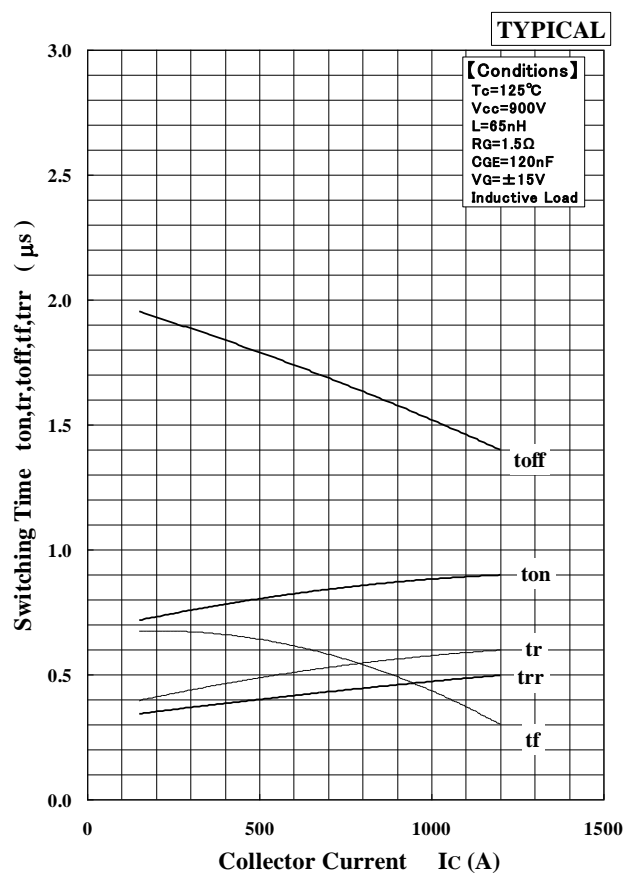
Turn-on Loss vs. Collector Current



Turn-off Loss vs. Collector Current

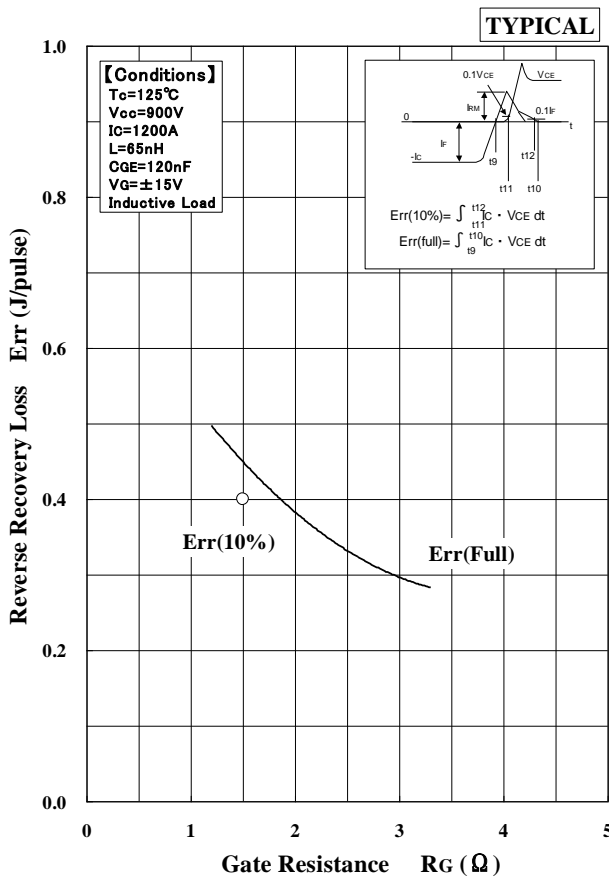
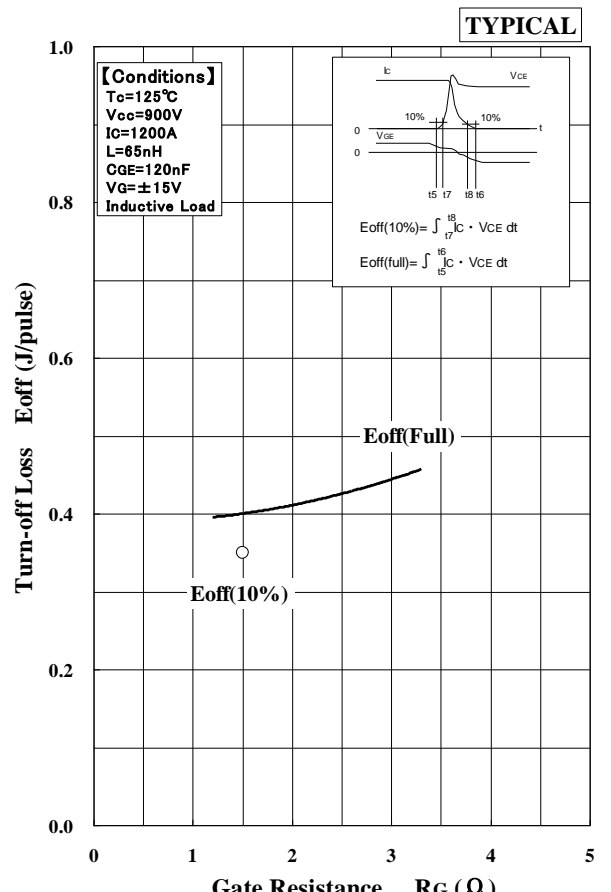
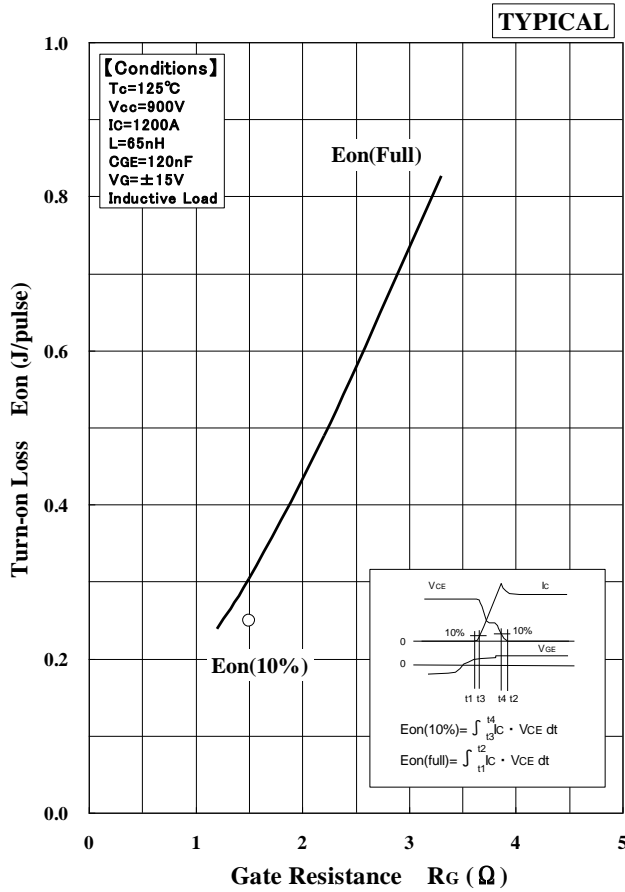


Recovery Loss vs. Forward Current



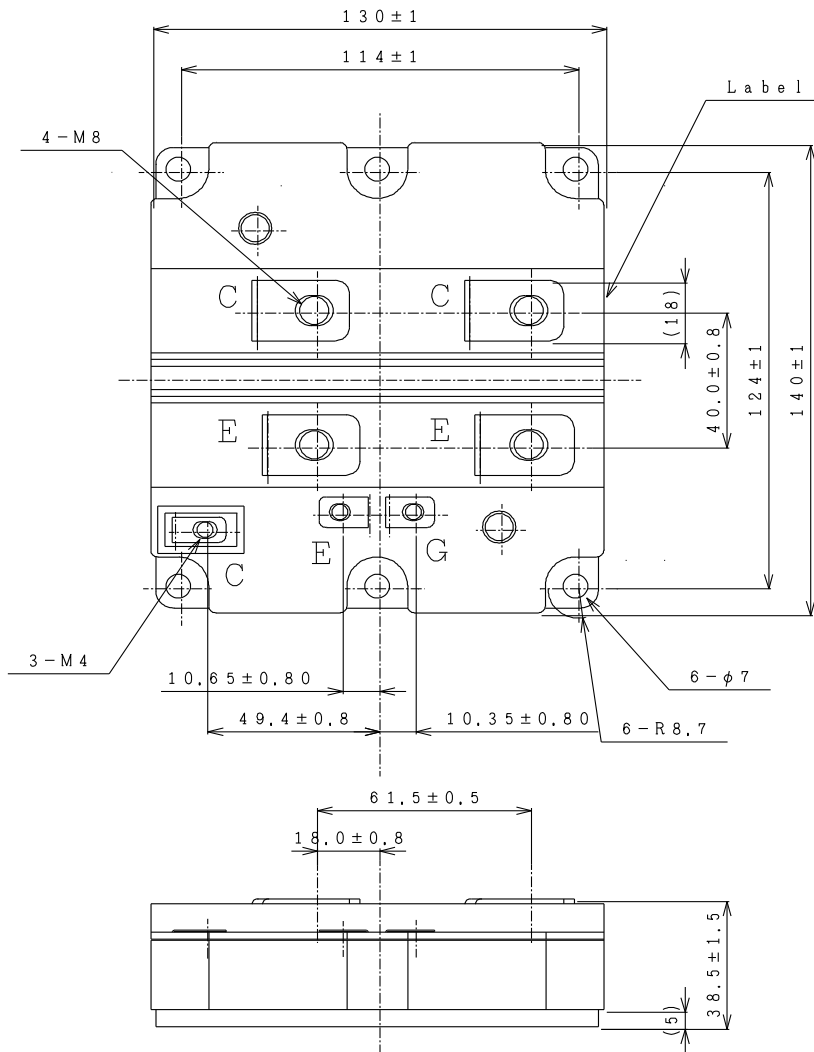
Switching Time vs. Collector Current

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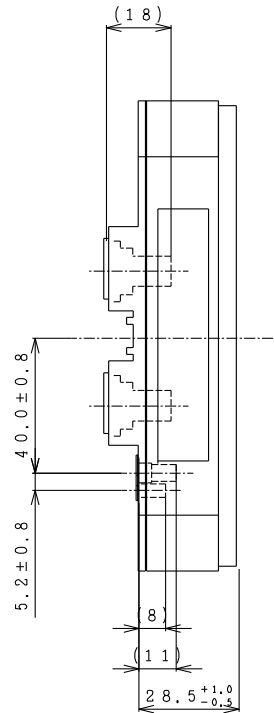


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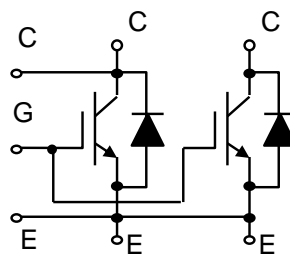
## PACKAGE OUTLINE DRAWING



Unit in mm



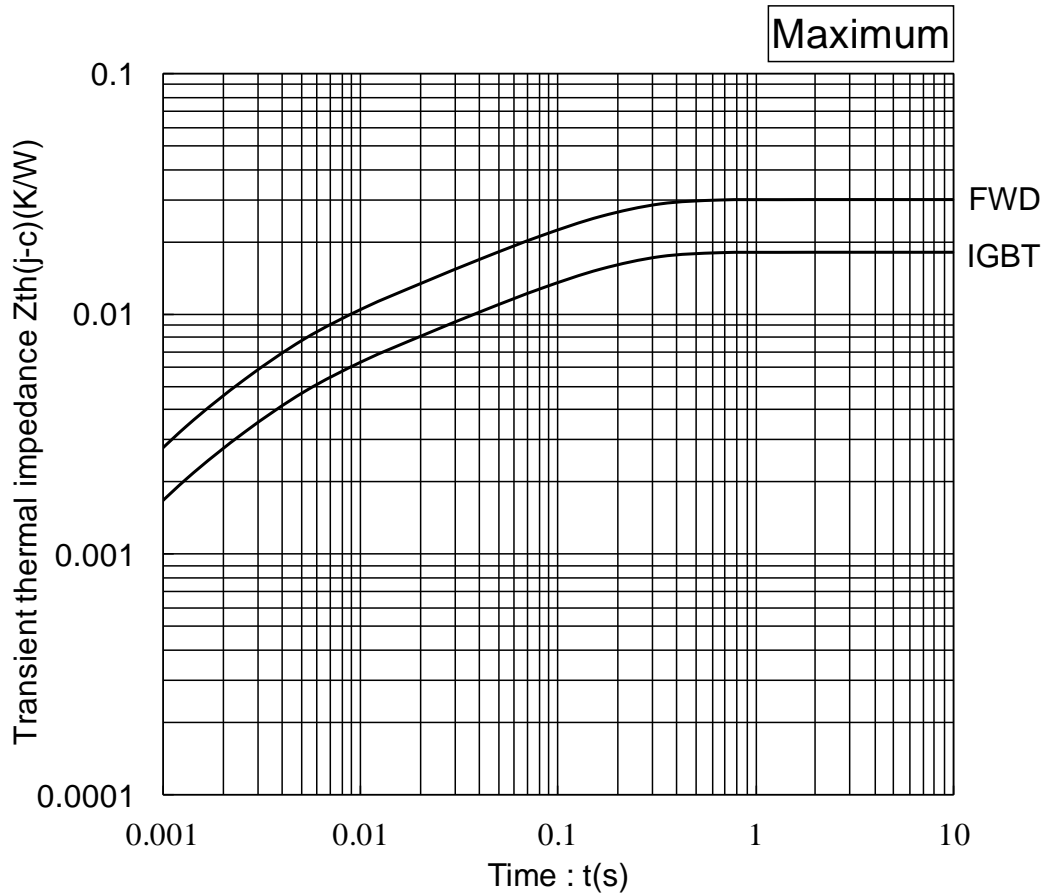
Weight: 900(g)



Circuit diagram

# MBN1200E17D

## TRANSIENT THERMAL IMPEDANCE



Transient Thermal Impedance Curve

### Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

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## HITACHI POWER SEMICONDUCTORS

### Notices

1. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact Hitachi sales department for the latest version of this data sheets.
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